

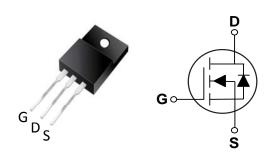
### **General Description**

The I2MNAB25H is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristic.

This power MOSFET is usually used in high speed switching applications including power supplies, PWM motor controls, high efficient AC to DC converters and bridge circuits.

| BV <sub>DSS</sub> | R <sub>DS(ON)</sub> | I <sub>D</sub> |
|-------------------|---------------------|----------------|
| 650 V             | 2.5 Ω               | 4 A            |

### TO-220F Pin Configuration



#### **Features**

- $R_{DS(ON)} \le 2.5 \Omega @V_{GS} = 10V$
- · Fast Switching Capability
- · Avalanche Energy Specified
- · Improved dv/dt Capability, High Ruggedness

| Symbol           | Parameter                              | Rating     | Units |
|------------------|--|------------|-------|
| $V_{DS}$         | Drain-Source Voltage                   | 650        | V     |
| $V_{GS}$         | Gate-Source Voltage                    | ±30        | V     |
| I <sub>D</sub>   | Drain Current - Continuous             | 4          | Α     |
| I <sub>DM</sub>  | Drain Current - Pulsed (NOTE 2)        | 16         | Α     |
| EAS              | Single Pulse Avalanche Energy (NOTE 3) | 113        | mJ    |
| $P_{D}$          | Power Dissipation                      | 36         | W     |
| ı D              | Power Dissipation - Derate above 25°C  | 0.29       | W/°C  |
| $T_J$            | Operating Junction Temperature Range   | -50 to 150 | °C    |
| T <sub>STG</sub> | Storage Temperature Range              | -50 to 150 | °C    |
| Marking Code     |  | NAB25H     |       |

#### NOTES:

- 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=25mH,  $I_{AS}$ =3A,  $V_{DD}$ =50V,  $R_{G}$ =25 $\Omega$ , Starting  $T_{J}$ = 25 $^{\circ}$ C

| Thermal Characteristics |  |      |      |      |  |
|-------------------------|--|------|------|------|--|
| Symbol                  | Parameter                              | Тур. | Max. | Unit |  |
| $R_{\theta JA}$         | Thermal Resistance Junction to Ambient |      | 62.5 | °C/W |  |
| $R_{	heta JC}$          | Thermal Resistance Junction to Case    |      | 3.4  | °C/W |  |





### Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)

### **Off Characteristics**

| Symbol            | Parameter                      | Conditions                                  | Min. | Тур. | Max. | Unit |
|-------------------|--------------------------------|---|------|------|------|------|
| BV <sub>DSS</sub> | Drain-Source Breakdown Voltage | $V_{GS}$ =0V , $I_D$ =250uA                 | 650  |      |      | V    |
| I <sub>DSS</sub>  | Drain-Source Leakage Current   | V <sub>DS</sub> =650V , V <sub>GS</sub> =0V |      |      | 10   | uA   |
| I <sub>GSS</sub>  | Gate-Source Leakage Current    | $V_{GS}$ =±30V , $V_{DS}$ =0V               |      |      | ±100 | nA   |

### On Characteristics

| Symbol              | Parameter                         | Conditions                    | Min. | Тур. | Max. | Unit |
|---------------------|-----------------------------------|-------------------------------|------|------|------|------|
| R <sub>DS(ON)</sub> | Static Drain-Source On-Resistance | $V_{GS}$ =10V , $I_D$ =2A     |      | 2.2  | 2.5  | Ω    |
| $V_{GS(th)}$        | Gate Threshold Voltage            | $V_{GS}=V_{DS}$ , $I_D=250uA$ | 2.0  |      | 4.0  | V    |

### **Dynamic and switching Characteristics**

| Symbol           | Parameter                    | Conditions  | Min. | Тур. | Max. | Unit |
|------------------|------------------------------|---|------|------|------|------|
| $Q_g$            | Total Gate Charge            | $V_{DS}$ =100V , $V_{GS}$ =10V , $I_{D}$ =3A ,        |      | 13   |      |      |
| $Q_{gs}$         | Gate-Source Charge           | I <sub>G</sub> =1mA                                   |      | 3.6  |      | nC   |
| $Q_{gd}$         | Gate-Drain Charge            | (NOTE 4 \ 5)  |      | 2    |      |      |
| $T_{d(on)}$      | Turn-On Delay Time           | V 400V V 40V D 050                                    |      | 30   |      |      |
| $T_r$            | Rise Time                    | $V_{DS}$ =100V , $V_{GS}$ =10V , $R_{G}$ =25 $\Omega$ |      | 10   |      | ns   |
| $T_{d(off)}$     | Turn-Off Delay Time          | (NOTE 4 \ 5)  |      | 60   |      | 115  |
| $T_f$            | Fall Time                    | (110121 0)  |      | 50   |      |      |
| $C_{iss}$        | Input Capacitance            |   |      | 600  |      |      |
| C <sub>oss</sub> | Output Capacitance           | $V_{DS}$ =25V , $V_{GS}$ =0V , F=1MHz                 |      | 53.8 |      | pF   |
| $C_{rss}$        | Reverse Transfer Capacitance |   |      | 3.2  |      |      |

### **Drain-Source Diode Characteristics and Ratings**

| Symbol          | Parameter                 | Conditions                                 | Min. | Тур. | Max. | Unit |
|-----------------|---------------------------|--|------|------|------|------|
| Is              | Continuous Source Current |  |      |      | 4    | Α    |
| I <sub>SM</sub> | Pulsed Source Current     |  |      |      | 16   | Α    |
| $V_{SD}$        | Diode Forward Voltage     | $V_{GS}$ =0V , $I_S$ =4A                   |      |      | 1.4  | V    |
| trr             | Reverse Recovery Time     | I <sub>S</sub> =4A , V <sub>GS</sub> =0V , |      | 230  |      | nS   |
| Qrr             | Reverse Recovery Charge   | dI <sub>F</sub> /dt=100A/µs (NOTE 4)       |      | 1.6  |      | uC   |

### NOTES:

- 4. Pulse test : pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 5. Essentially independent of operating temperature.





### **Test Circuits And Waveforms**

FIG. 1-Peak Diode Recovery dv/dt Test Circuit

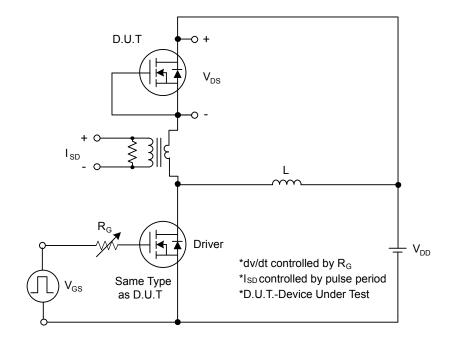
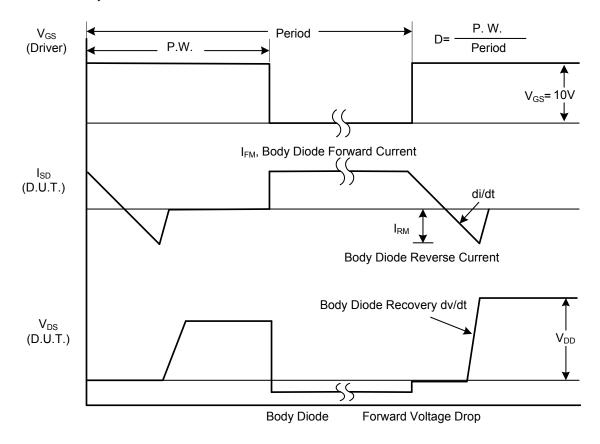


FIG. 2-Peak Diode Recovery dv/dt Waveforms







### **Test Circuits And Waveforms**

FIG. 3-Switching Test Circuit

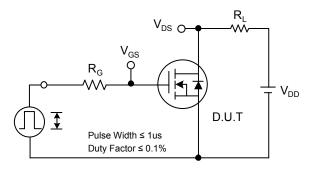


FIG. 4-Switching Waveforms

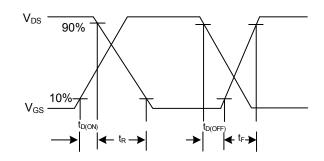


FIG. 5-Gate Charge Test Circuit

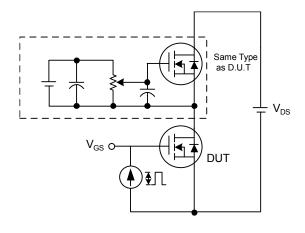


FIG. 6-Gate Charge Waveform

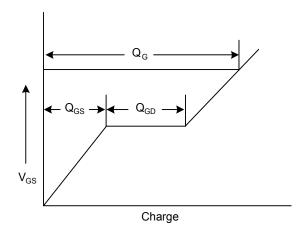


FIG. 7-Unclamped Inductive Switching Test Circuit

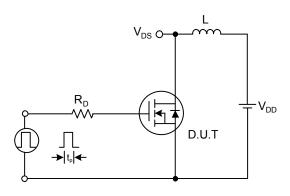
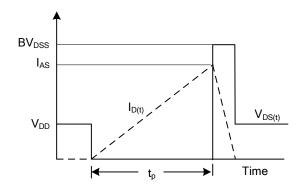


FIG. 8-Unclamped Inductive Switching Waveforms







#### **Characteristics Curves**

FIG. 1-Transfer Characteristics

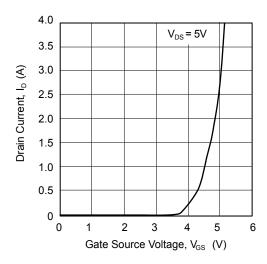


FIG. 2-Drain Current vs. Gate Threshold Voltage

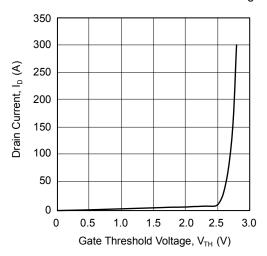


FIG. 3-Drain Current vs. Drain-Source Breakdown Voltage

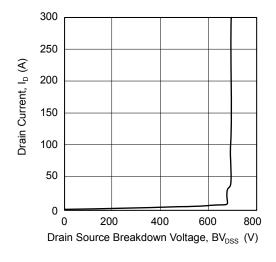


FIG. 4-On State Characteristics

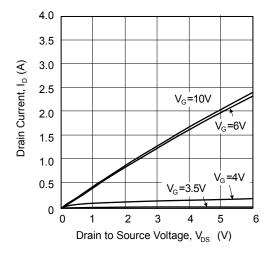


FIG. 5-Drain to Source On Resistance vs. Drain Current

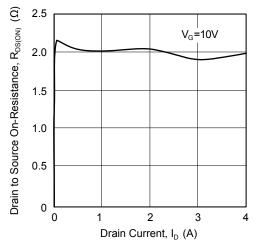
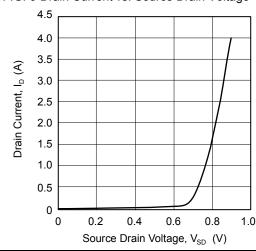


FIG. 6-Drain Current vs. Source Drain Voltage

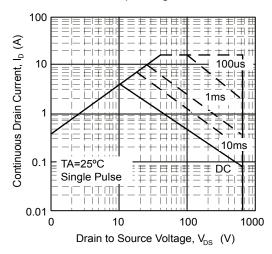




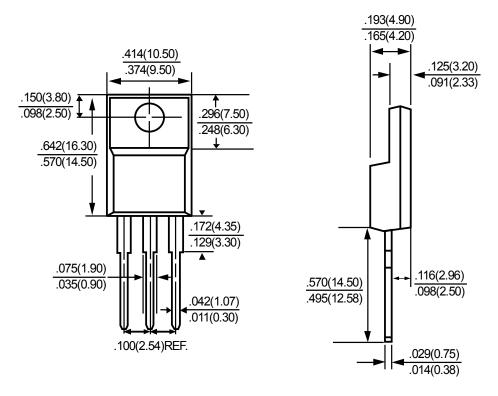


### **Characteristics Curves**

FIG. 7-Maximum Safe Operating Area



### **Package Outline Dimensions**



**TO-220F**Dimensions in inches and (millimeters)





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